

The Measurement of the $W\gamma$ Cross Section at 8 TeV (PhD thesis defense)

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Talk Outline

► Introduction to the Standard Model

► Theory

- Electroweak interactions
- Triple and quartic gauge couplings
- $W\gamma \rightarrow l\nu\gamma$ process

► Experimental setup

- Large Hadron Collider (LHC)
- Proton-proton collisions
- Compact Muon Solenoid (CMS)
- Particle reconstruction in CMS

► $W\gamma$ cross section measurement

- Measurement goal and strategy
- Data and simulation (MC) samples
- Event selection
- Background estimation
 - Methods and results
 - Challenges and cross checks
- Selected corrections
- Systematic uncertainties
- Cross section

► Acknowledgements

► Conclusions

Introduction. The Standard Model

About the Standard Model

Theory. EWK Interactions

Theory. Anomalous Gauge Couplings

Theory. $W\gamma \rightarrow l\nu\gamma$

W decay channels:

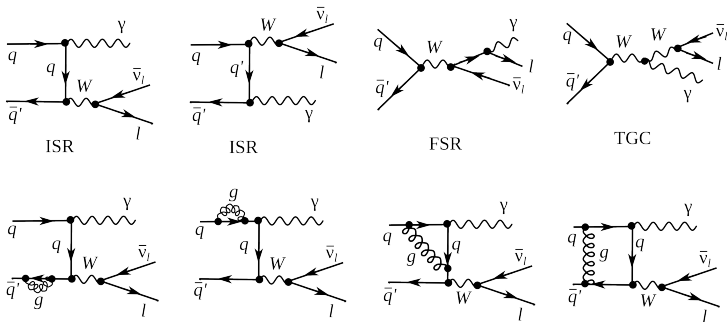


Figure: The Feynman diagrams. ISR(x2), FSR, and TGC.

- test Standard Model;
- search for aTGC.

Large Hadron Collider (LHC)

Proton-Proton Collisions

Compact Muon Solenoid (CMS). Components

Compact Muon Solenoid (CMS). Particle Reconstruction

Neutrino. Missing Transverse Energy

Measurement Goal

- ▶ Process: $W\gamma \rightarrow \mu\nu\gamma$ and $W\gamma \rightarrow e\nu\gamma$.
- ▶ Observables: the total and the differential ($\frac{d\sigma}{dP_T^\gamma}$) cross sections.
- ▶ Data: CMS, 2012, $\sqrt{s}=8$ TeV (datasets are discussed later).

Phase space definition:

- ▶ $p_T^\gamma > 15$ GeV
- ▶ $\Delta R(\gamma, lep) > 0.7$
- ▶ $|\eta^\gamma| < 2.5$, $|\eta^{lep}| < 2.5$
- ▶ $p_T^{lep} > 20$ GeV
- ▶ $Iso^\gamma < 5$ GeV
- ▶ for differential cross section, P_T^γ binning:
15-20-25-30-35-45-55-65-75-85-95-120-500 GeV

Measurement Strategy

Step	$d\sigma/dP_T$	σ
select events	N_{sel}^j	N_{sel}
subtract background	$N_{sign}^j = N_{sel}^j - N_{bkg}^j$	$N_{sign} = N_{sel} - N_{bkg}$
unfold	$N_{A \times \epsilon}^i = U_{ij} \cdot N_{sign}^j$	—
correct for the acceptance and efficiency	$N_{true}^i = \frac{N_{A \times \epsilon}^i}{(A \times \epsilon)^i}$	$N_{true} = \frac{N_{sign}}{A \times \epsilon}$
divide by luminosity and bin width	$\left(\frac{d\sigma}{dP_T^\gamma}\right)^i = \frac{N_{true}^i}{L \cdot (\Delta P_T^\gamma)^i}$	$\sigma = N_{true}/L$
estimate systematic uncertainties		

Data Samples and Triggering

The data sample we use in this measurement was recorded by the CMS experiment in 2012 in LHC pp collisions at $\sqrt{s}=8$ TeV. Integrated luminosity of the dataset is $L=19.6 \text{ fb}^{-1}$.

Dataset	Candidates	Purpose	Size, T
Single muon	$W\gamma \rightarrow \mu\nu\gamma$	target process	1.2
Single electron	$W\gamma \rightarrow e\nu\gamma$	target process	2.0
Double muon	$Z\gamma \rightarrow \mu\mu\gamma$	background estimation	0.4
Double electron	$Z\gamma \rightarrow ee\gamma$	background estimation	0.5

MC Samples and Luminosity Reweighting

Process	Type	σ , pb
$W\gamma \rightarrow l\nu\gamma$	signal	554
$W+\text{jets} \rightarrow l\nu+\text{jets}$	background	36257
$DY+\text{jets} \rightarrow ll+\text{jets}$	background	3504
$t\bar{t}+\text{jets} \rightarrow 1l+X$	background	99
$t\bar{t}+\text{jets} \rightarrow 2l+X$	background	24
$Z\gamma \rightarrow ll\gamma$	background	172

All MC samples are normalized to the data luminosity of $L = 19.6 \text{ fb}^{-1}$ in all studies and plots.

Requirements for Selection of $W\gamma$ Candidates

- - - - - Muon Channel - - - - -		- - - - - Electron Channel - - - - -	
Exactly one lepton + at least one photon			
Photon selection:			
medium ID; $p_T > 15$; $ \eta < 1.4442$ or $1.566 < \eta < 2.5$		ElectronConversionVeto→PixelSeedVeto	
Muon tight ID		Electron tight ID	
$p_T^\mu > 25$ GeV; $ \eta^\mu < 2.1$		$p_T^{ele} > 30$; $ \eta^{ele} < 1.4442$ or $1.566 < \eta^{ele} < 2.5$	
Second lepton veto:			
$p_T^{\mu 2} > 10$ GeV; $ \eta^{\mu 2} < 2.4$		$p_T^{ele 2} > 10$; $ \eta^{ele 2} < 1.4442$ or $1.566 < \eta^{ele 2} < 2.5$; veto ID for ele2	
$M_T^W > 40$ GeV (discussed later)			
		$110 \text{ GeV} > M_{e\gamma} > 70 \text{ GeV}$ excluded (discussed later)	
$\Delta R(lep, \gamma) > 0.7$			

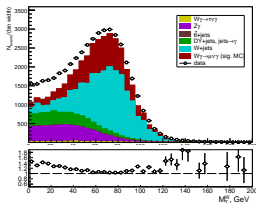
Data vs MC. M_T^W and $M_{l,\gamma}$

$M_T^W > 40 \text{ GeV}$ is applied in both channels

$M_{l,\gamma} < 70 \text{ or } M_{l,\gamma} > 110 \text{ GeV}$ is applied in the **electron channel only**

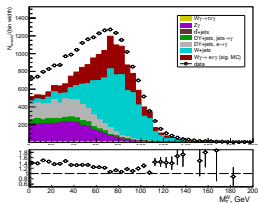
Work in progress, CMS 2012, $\sqrt{s}=8 \text{ TeV}$, $L=19.6 \text{ fb}^{-1}$

Data vs MC. $W\gamma \rightarrow \mu\nu\gamma$, EB+EE.



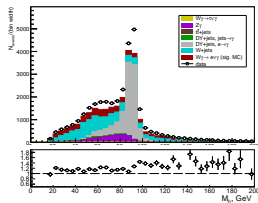
Work in progress, CMS 2012, $\sqrt{s}=8 \text{ TeV}$, $L=19.6 \text{ fb}^{-1}$

Data vs MC. $W\gamma \rightarrow e\nu\gamma$, EB+EE.



Work in progress, CMS 2012, $\sqrt{s}=8 \text{ TeV}$, $L=19.6 \text{ fb}^{-1}$

Data vs MC. $W\gamma \rightarrow e\nu\gamma$, EB+EE.

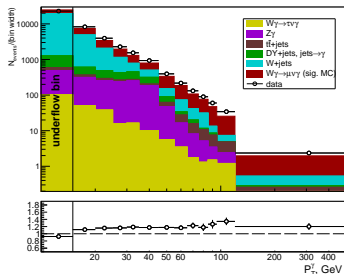


Data vs MC. P_T^γ

- selected datasets in both channels are dominated by W +jets events

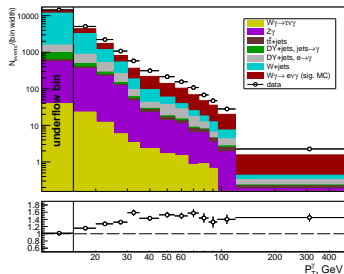
Work in progress, CMS 2012, $\sqrt{s}=8$ TeV, $L=19.6$ fb $^{-1}$

Data vs MC. $W\gamma \rightarrow \mu\nu\gamma$, barrel.



Work in progress, CMS 2012, $\sqrt{s}=8$ TeV, $L=19.6$ fb $^{-1}$

Data vs MC. $W\gamma \rightarrow e\nu\gamma$, barrel.



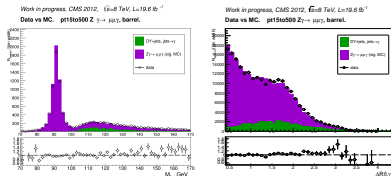
Jets $\rightarrow \gamma$ Background. Sources

Jets $\rightarrow \gamma$ background estimation is the most challenging part of this measurement and also the source of the largest systematic uncertainties (discussed later).

Jets $\rightarrow \gamma$ Background. Template Method

- Fit function: $F(V_{fit}) = N_{true} \cdot T_{true}(V_{fit}) + N_{fake} \cdot T_{fake}(V_{fit})$

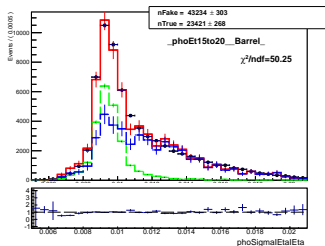
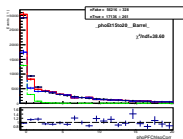
Jets $\rightarrow \gamma$ Background. Templates from $Z\gamma \rightarrow \bar{\mu}\mu\gamma$



FSR selection: $M_{\mu\mu\gamma} < 101$ GeV and $\Delta R(\mu_1, \gamma) > 0.4$

ISR selection: $M_{\mu\mu\gamma} > 101$ GeV and $\Delta R(\mu_1, \gamma) > 1.0$

Jets $\rightarrow \gamma$ Background. $V_{fit} = I_{ch}^{\gamma}$ and $V_{fit} = \sigma_{i\eta i\eta}$



$e \rightarrow \gamma$ Background. Source

$e \rightarrow \gamma$ Background. Method Description

Method Description

- ▶ Get $N_{MC-Zpeak}^{e \rightarrow \gamma}$ (number of $e \rightarrow \gamma$ events under the Z-peak based on the MC prediction); done by counting
- ▶ Get $N_{data-Zpeak}^{e \rightarrow \gamma}$ (number of $e \rightarrow \gamma$ events under the Z-peak from data); done by fitting
- ▶ Get $N_{MC-nom}^{e \rightarrow \gamma}$ (number of $e \rightarrow \gamma$ events in the nominal range based on the MC prediction); done by counting
- ▶ Get $N_{data-nom}^{e \rightarrow \gamma}$ (number of $e \rightarrow \gamma$ events in the nominal range based on the MC prediction from data); done by scaling
$$N_{data-nom}^{e \rightarrow \gamma} = N_{MC-nom}^{e \rightarrow \gamma} \cdot N_{data-Zpeak}^{e \rightarrow \gamma} / N_{MC-Zpeak}^{e \rightarrow \gamma}$$

$M_{e,\gamma}$ Fit Model and Fit Plots. 15-20 GeV, barrel

$$N_{sig} \cdot (RooNDKeysPdf \times Gaussian) + N_{bkg} \cdot (RooCMSShapePdf)$$

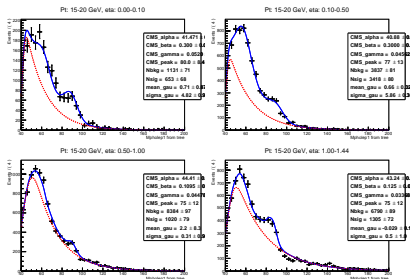


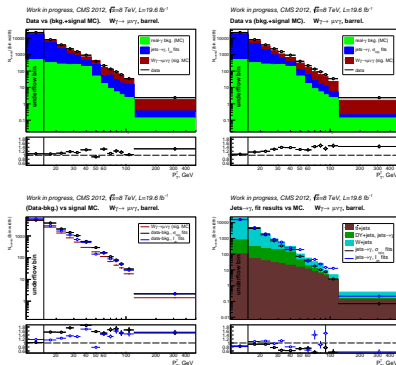
Figure: $M_{e,\gamma}$ fits, W_γ , electron channel, 15-20 GeV, barrel, 4 eta bins

Real- γ Background

Main sources of true γ background are $Z\gamma$ and $W\gamma \rightarrow \tau\nu\gamma$. The MC-based estimation is used to subtract these backgrounds.
MC-based background estimation.

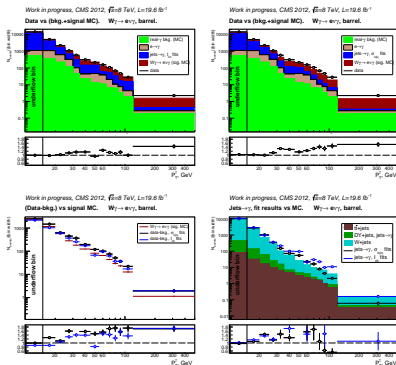
P_T^γ Spectrum before and after Background Subtraction. Muon Channel, Barrel

Top: data vs fake- γ background derived from the template method + real- γ background predicted by dedicated MC samples + signal MC, with I_{ch} and $\sigma_{in\eta}$ used as fit variables. Bottom: left: data yields after full background subtraction vs signal MC. I_{ch} vs $\sigma_{in\eta}$ fit results. Right: fake- γ data driven background prediction vs MC. Plotted with the stat error only. Disagreement



P_T^γ Spectrum before and after Background Subtraction. Electron Channel, Barrel

Top: data vs fake- γ background derived from the template method + real- γ background predicted by dedicated MC samples + signal MC, with I_{ch} and $\sigma_{in\eta}$ used as fit variables. Bottom: left: data yields after full background subtraction vs signal MC. I_{ch} vs $\sigma_{in\eta}$ fit results. Right: fake- γ data driven background prediction vs MC. Plotted with the stat error only.



Cross Checks for Jets $\rightarrow \gamma$ Background Estimation

Simple MC closure check:

MC realistic check:

$Z\gamma$ check:

Conclusions:

Other Corrections

Detector resolution unfolding: Important note: errors across different P_T^γ bins become correlated after the unfolding procedure.

Efficiency:

Acceptance:

Efficiency Scale Factors

POG

Special SF from $W\gamma$

Systematic Uncertainties. Introduction

Relative Systematic Uncertainties [%] in the Muon Channel. Table

P_T^γ , GeV	err stat	syst $ N_{lch} - N_{\sigma i n i \eta} $	$Z\gamma$ MC norm	templ stat	SFs err	syst lumi	syst other	syst total
total	1	10	24	4	2	3	4	27
15-20	2	31	12	10	3	3	6	35
20-25	2	29	13	11	1	3	6	34
25-30	2	24	13	11	1	3	5	30
30-35	3	40	15	13	2	3	7	45
35-45	2	11	12	8	2	3	6	19
45-55	4	62	19	20	2	3	8	68
55-65	3	15	12	14	1	3	7	24
65-75	6	36	19	17	1	3	10	44
75-85	4	6	11	16	1	3	10	21
85-95	5	2	9	23	1	3	13	25
95-120	5	10	8	12	1	3	9	18
120-500	3	4	11	21	2	3	9	24

Relative Systematic Uncertainties [%] in the Electron Channel. Table

P_T^γ , GeV	err stat	syst $ N_{lch} - N_{\sigma i \eta i \eta} $	$Z\gamma$ MC norm	templ stat	SFs err	syst lumi	$e \rightarrow \gamma$	syst other	syst total
total	2	15	35	5	19	3	4	5	44
15-20	8	80	27	19	17	3	18	11	90
20-25	7	38	20	14	12	3	11	10	48
25-30	5	25	16	12	14	3	8	8	36
30-35	5	35	14	12	14	3	3	8	42
35-45	3	14	13	8	18	3	2	7	28
45-55	8	53	20	22	36	3	7	11	71
55-65	7	17	12	30	44	3	5	10	58
65-75	7	23	15	32	44	3	4	11	61
75-85	8	32	17	27	44	3	6	13	64
85-95	9	9	7	9	40	3	8	14	44
95-120	7	19	9	14	44	3	5	11	51
120-500	4	12	6	24	39	3	1	9	48

Major Sources of the Systematic Uncertainties

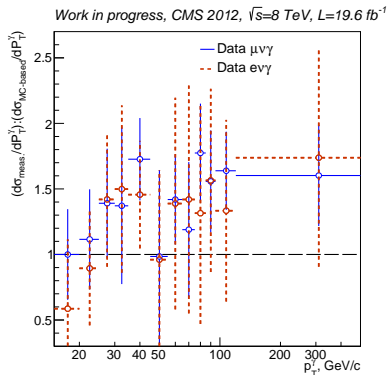
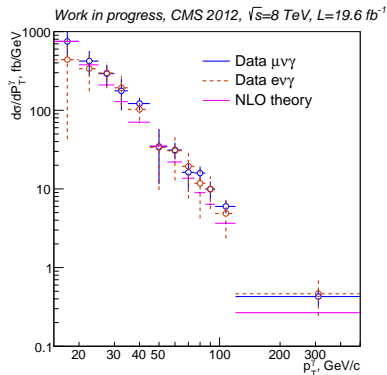
Bias in Template Shape and Fit Machinery: $|N_{lch} - N_{\sigma i \eta i \eta}|$

$Z\gamma$ MC Normalization:

Statistical Power of Templates:

PixelSeedVeto SFs (electron channel only):

Total and Differential Cross Section



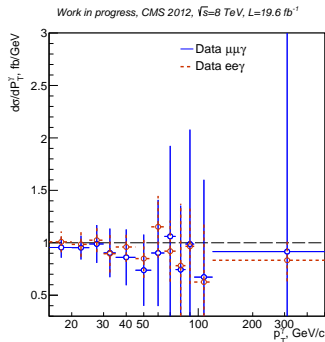
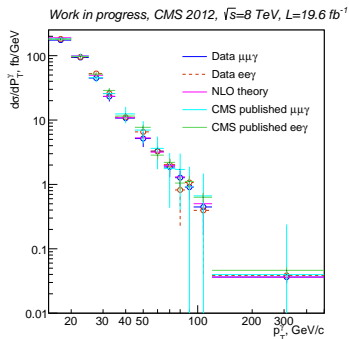
Total cross section ($P_T^\gamma > 15$ GeV):

MC-based: $\sigma = 9101$ fb

Measured, muon channel: $\sigma = 10949 \pm 91 \pm 1463$ fb

Measured, electron channel: $\sigma = 9146 \pm 185 \pm 2213$ fb

ZGamma check. Differential Cross Section



- ▶ Total and differential cross section of $Z\gamma \rightarrow ll\gamma$ is measured and agrees well with the 8 TeV published CMS result as well as with the theory prediction;
- ▶ The workflows for the $Z\gamma$ and $W\gamma$ are very similar, and we used the same procedures of the jets $\rightarrow \gamma$ background estimation;
- ▶ For the muon channel, data used for preparing templates significantly overlap with the dataset, thus, the result is a closure test rather than a valid physics measurement;
- ▶ For the electron channel, templates and the dataset are independent, thus, the result is a valid physics measurement.

Acknowledgements

Before drawing conclusions...

- ▶ Ilya Kravchenko, Yurii Maravin, Lovedeep Saini;
- ▶ Joshua Kunkle, Senka Duric, Dmytro Kovalskyi;
- ▶ Kuo Chia-Ming, Sachiko Toda McBride, Yutaro Iiyama;
- ▶ whole CMS collaboration.

Conclusions

- ▶ Cross section for muon and electron channels are computed;
- ▶ This is the first measurement of the differential $W\gamma$ cross section with CMS;
- ▶ Results agree with the theory;
- ▶ Results between the two channels agree;
- ▶ Good agreement in the $Z\gamma$ check validates most parts of the measurement.